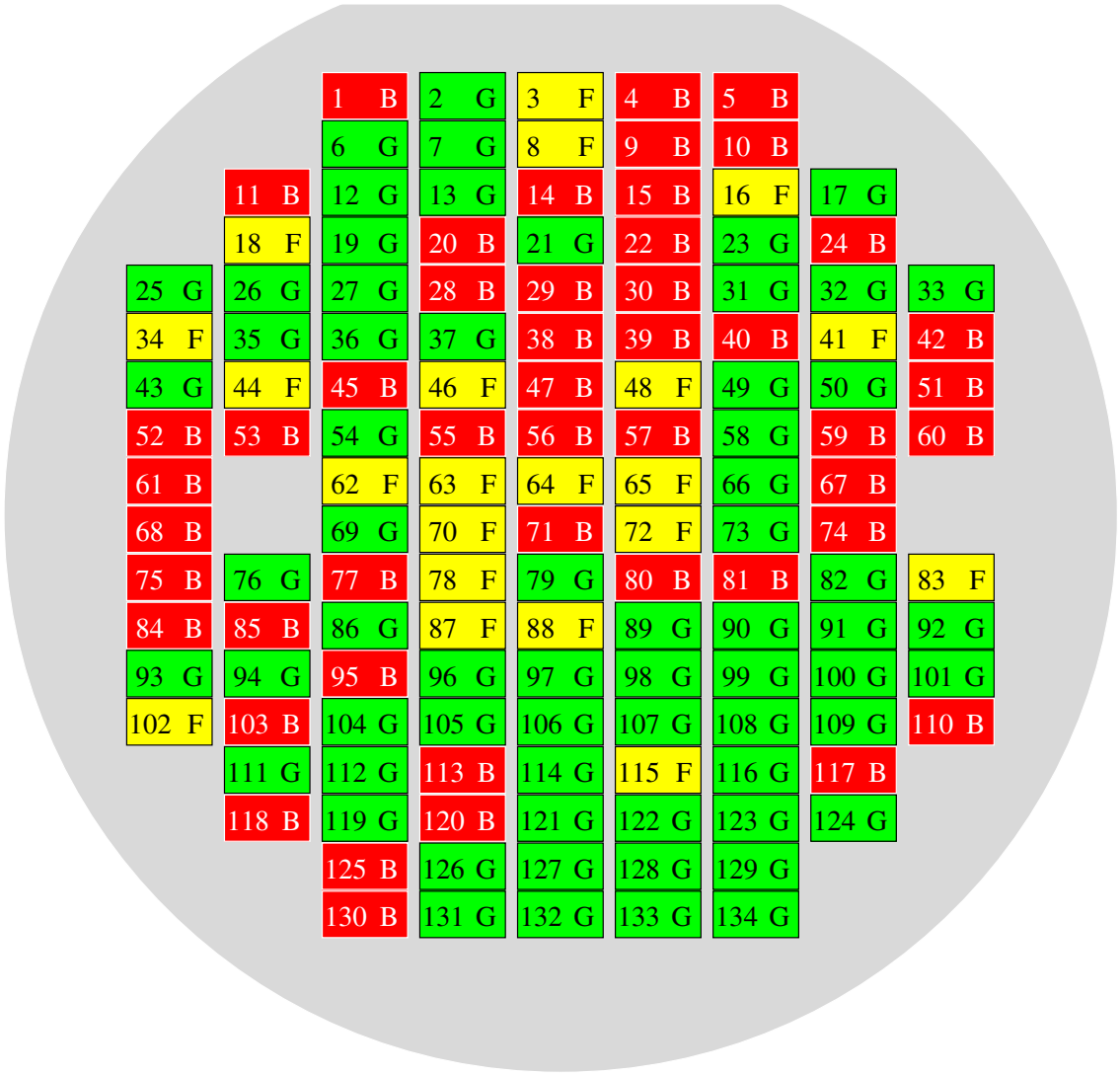
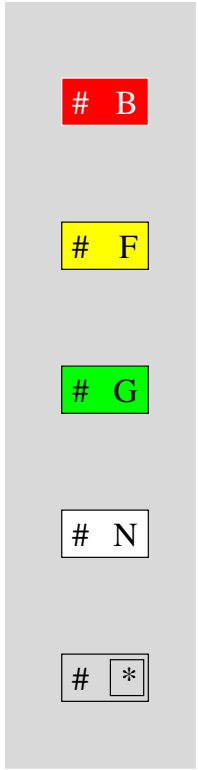
Die quality map for wafer 168 s/n: Y21316-12-06

Date: 07/06/99





Bad die

Fair die

Good die

No info

Manually tagged